

Notice of References Cited

Application/Control No.

10/073,304

Examiner

James Phan

Applicant(s)/Patent Under
Reexamination
YASUDA ET AL.

Art Unit
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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,556,333	04-2003	Tokuda et al.	359/224
	В	US-			
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NON-PATENT DOCUMENTS

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